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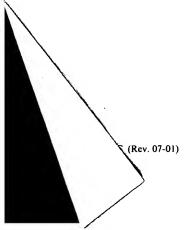


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| APPLICATION NO. | FILING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO. |
|--|-----------------|-------------------------|---------------------|------------------|
| 09/837,265 | 04/19/2001 | Kenneth H. Church | CMS | |
| 7 | 7590 04/05/2002 | | | |
| James C. Wray Suite 300 1493 Chain Bridge Road | | | EXAMINER | |
| | | | FULLER, ERIC B | |
| McLean, VA | 22101 | | ART UNIT | PAPER NUMBER |
| | | | 1762 | 5 |
| | | DATE MAILED: 04/05/2002 | | |

Please find below and/or attached an Office communication concerning this application or proceeding.



| • | _ | | | 1-D-5 | | | |
|---|--|---|---|---------------------|--|--|--|
| | | Application No. | Applicant(s) | | | | |
| ٦ | | 09/837,265 | CHURCH ET AL. | | | | |
| Offic Action S | ummary | Examiner | Art Unit | | | | |
| | | Eric B Fuller | 1762 | | | | |
| | this communication | appears on the cover sheet | with the correspondence ad | dress | | | |
| Period for Reply | N DEDIOD FOR RE | DI V IQ GET TO EYDIRE 2 | MONTH(S) FROM | | | | |
| A SHORTENED STATUTOF THE MAILING DATE OF TH - Extensions of time may be available u after SIX (6) MONTHS from the mailin - If the period for reply specified above - If NO period for reply is specified abov - Failure to reply within the set or exten - Any reply received by the Office later of the period patent term adjustment. See 3 | IS COMMUNICATIO nder the provisions of 37 CFR g date of this communication. is less than thirty (30) days, a ve, the maximum statutory per ded period for reply will, by stathan three months after the maximum safer safer the maximum safer sa | N. 8.1.136(a). In no event, however, may reply within the statutory minimum of the did will apply and will expire SIX (6) Months. cause the application to become | a reply be timely filed nirty (30) days will be considered timel DNTHS from the mailing date of this ca ABANDONED (35 U.S.C. § 133). | y. ommunication. | | | |
| 1) Responsive to comm | unication(s) filed on 2 | 25 February 2002 . | | | | | |
| 2a) This action is FINAL . | | This action is non-final. | | | | | |
| / | <i>,</i> — | owance except for formal m | atters, prosecution as to th | e merits is | | | |
| closed in accordance Disposition of Claims | with the practice und | der <i>Ex parte Quayle</i> , 1935 (| C.D. 11, 453 O.G. 213. | | | | |
| 4)⊠ Claim(s) <u>1-46</u> is/are p | ending in the applica | tion. | | | | | |
| 4a) Of the above claim | (s) <u>29-42</u> is/are withd | lrawn from consideration. | | | | | |
| 5) Claim(s) is/are | allowed. | | | | | | |
| 6)⊠ Claim(s) <u>1-28 and 43-</u> | 46 is/are rejected. | | | | | | |
| 7) Claim(s) is/are | objected to. | | | | | | |
| 8) Claim(s) are su | bject to restriction an | d/or election requirement. | | | | | |
| Application Papers | | | | | | | |
| 9) The specification is obj | - | | | | | | |
| 10) ☐ The drawing(s) filed on | | | | | | | |
| | | o the drawing(s) be held in abo | | | | | |
| 11) The proposed drawing | | | disapproved by the Examin | er. | | | |
| If approved, corrected drawings are required in reply to this Office action. | | | | | | | |
| 12) The oath or declaration | | examiner. | | | | | |
| Priority under 35 U.S.C. §§ 119 | | | 0.440(.) (1) (0) | | | | |
| 13) Acknowledgment is m | | eign priority under 35 U.S.C | s. § 119(a)-(d) or (f). | | | | |
| a) ☐ All b) ☐ Some * c) | | | • | | | | |
| | | ents have been received. | | | | | |
| | | ents have been received in | | • | | | |
| application f | rom the International | oriority documents have been Bureau (PCT Rule 17.2(a)) list of the certified copies no |). | Stage | | | |
| 14)⊠ Acknowledgment is mad | de of a claim for dom | estic priority under 35 U.S.0 | C. § 119(e) (to a provisiona | I application). | | | |
| a) ☐ The translation of 15)☐ Acknowledgment is ma | | provisional application has estic priority under 35 U.S. | | | | | |
| Attachment(s) | | | | | | | |
| Notice of References Cited (PTO- Notice of Draftsperson's Patent D Information Disclosure Statement | rawing Review (PTO-948) | 5) Notice | w Summary (PTO-413) Paper No of Informal Patent Application (PT | | | | |

DETAILED ACTION

Response to Revocation and Substitute Power of Attorney

The Revocation and Substitute Power of Attorney has been received but has not been entered. Certification or a Reel and Frame number is required.

Election/Restrictions

Applicant's election of Group I, claims 1-28 and newly added claims 43-46, in Paper No. 3 is acknowledged. Because applicant did not distinctly and specifically point out the supposed errors in the restriction requirement, the election has been treated as an election without traverse (MPEP § 818.03(a)).

Claims 29-42 have been withdrawn from further consideration.

Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 6, 11 and 24-28 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

As to claim 6, "stops the adhesion" is confusing. As claimed, it is unclear if the increase in adhesion is stopped by the creation of a thermal gradient or if all adhesive forces are stopped, resulting in a layer that does not adhere to the substrate. For

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examination purposes, a stop in the increase of adhesion is assumed by the examiner as the purpose of sintering is to have a layer adhered to the substrate.

As to claim 11, "a gigawatt range" is vague and indefinite. It is unclear to the examiner what values would or would not constitute a gigawatt range, such as if .01 gigawatts is sufficient.

As to claim 24, "small spot size" is a relative term that renders that claim indefinite.

As to claim 25-28, "the pyrometer" lacks antecedent basis.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-3, 7-10, 13, 14, 21, and 22 are rejected under 35 U.S.C. 102(b) as being anticipated by Kirkpatrick (US 4,151,008).

As to claims 1-3, Kirkpatrick teaches a process where a laser is used to perform a heat treatment process on a substrate. The treatment may be sintering a metal-semiconductor interface (column 5, lines 55-60). The laser is aimed at the material to be sintered and in doing so creates the thermal energy needed (column 4, lines 4-10). The pulse duration of the laser is set such that only selected surface vicinity regions are

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heated and that the substrate is not subjected to undesirable high temperatures (column 6, lines 1-7; column 2, lines 1-10), thus reading on "without damaging the substrate".

As to claim 7, the exposure times for providing complete heating are set (column 1, lines 53-68; column 3, lines 50-51).

As to claim 8, the reference teaches a process for localizing the heat such that heat is not dissipated from the process region (column 3, lines 55-57). However, for the embodiment of where the metal-semiconductor interface is being sintered, the entire metal material would be considered the process area and diffusion of heat throughout the metal material would be inherent.

As to claim 9, the laser provides high energy that is injected into the material and the material translates this injected energy into heat (column 4, lines 4-10).

As to claim 10, the absorption behavior and effects of pulse duration have been determined in the reference (column 1, lines 54-58; column 2, lines 1-56).

As to claim 13, the reference, in one embodiment, teaches to sinter only surface vicinity regions (column 6, line 6). This reads on not sintering a middle or bottom layer.

As to claim 14, controlling the pulse duration of the laser determines the penetration depth of the energy injected into the material (column 3, lines 46-60).

As to claim 21, the selected surface vicinity being sintered in the reference qualifies as "sintering at least one thin top layer of the material".

As to claim 22, the effect of a mirror forming on the top layer of the material, such that energy is diverted from the material in order to prevent sintering from occurring throughout the material, would be inherent to the process of sintering only the selected

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surface vicinity of a metal material. The examiner's position on this being an inherent process is due to the materials and laser parameters of the reference are similar to that of the applicantion.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-6 are rejected under 35 U.S.C. 103(a) as being unpatentable over Sopori (US 5,223,453).

Sopori teaches a process where metal is deposited on top and on bottom of a semiconductor substrate (abstract). The metal on the top is to be sintered and the metal on the bottom is to be alloyed. This is done without overheating the sintered material or the substrate (column 4, lines 54-61), thus reading on "without damaging the substrate". Illuminating the substrate, with the two layers deposited on it, with electromagnetic radiation (column 5, lines 24-50) through the top layer (the layer that is to be sintered) performs both the alloying and the sintering. The radiation causes the surface of the top layer to convert some of the energy to heat. The substrate also heats up, from the bottom, as a result of the radiation. This causes the thermal energy to spread throughout the top layer. The reference teaches that the radiation is produced

from a radiation lamp. However, to substitute a laser for the lamp would have been obvious to one of ordinary skill in the art. By doing so, more control of the radiation to selected areas is possible. This reads on the limitations of claims 1-4.

As to claim 5, during radiation, the top layer is being sintered and adhesion to the substrate is being promoted. The teaching of hot spots and secondary hot spots (column 6, lines 41-68) shows that the temperatures of the substrate and the top material, at the interface, are similar during radiation.

As to claim 6, when the radiation is stopped, the sintering stops. There would be no increase in adhesion after the sintering has stopped as a result of the radiation stopping. The teachings of hot spots and secondary hot spots (column 6, lines 41-68) shows that the hottest spot of the system, during radiation, would exist at the bottom of the substrate. Because of this uneven heating and the differences in thermal conductivity between the substrate and the metal material, the cooling of the system after the radiation has stopped would not be uniform. This results in a temperature gradient between the top material and the substrate. This reads on the "temperature gradient stops the adhesion".

Claims 11, 12, 15, 16, and 23 rejected under 35 U.S.C. 103(a) as being unpatentable over Kirkpatrick (US 4,151,008).

Kirkpatrick teaches the limitations of claims 1, 2, 10, and 22 as shown above. As to claim 11, the reference also teaches to use low energy per pulse and short pulse durations. The reference is silent to the peak power being in the gigawatt range.

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However, it would have been obvious at the time the invention was made to a person having ordinary skill in the art to use peak powers sufficient enough to sinter the metal material without causing damage to the substrate. To determine what this value is would be within the skill of one practicing in the art through routine experimentation. It is the examiners position that since the reference is using energies and pulse durations near that of the applicant, the peak power that is sufficient to sinter the material would be within the applicant's claimed range.

As to claim 12, Kirkpatrick teaches to control the pulse duration to achieve the desired energy penetration, but is silent to optimizing it. However, optimizing a parameter is obvious to one skilled in the art.

As to claim 15, Kirkpatrick teaches to sinter the metal-semiconductor interface to improve mechanical adherence (column 5, lines 55-60). It would have been obvious at the time the invention was made to a person having ordinary skill in the art, from reading this line, to control the pulse duration such that the penetration depth of the energy is equal to the thickness of the metal material.

As to claim 16, Kirkpatrick fails to teach to monitor the behavior of the heat in the material. However, to do so would have been obvious to one skilled in the art in order to achieve uniformity and reproducibility of multiple applications of the process. A thermal-imaging camera, being known in the art, would have been an obvious way to do this.

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As to claim 23, to have a feedback control system would also have been obvious at the time the invention was made to a person having ordinary skill in the art in order to ensure reproducibility of the process.

Claims 17-20 and 41-46 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kirkpatrick (US 4,151,008) as applied to claim 1 above, and further in view of Ladd et al. (US 6,100,463).

Kirkpatrick teaches the limitations of claim 1 and further teaches that it is undesirable to subject semiconductor substrates devices to high temperatures (column 2, lines 5-10). Kirkpatrick fails to teach the use of a thermal barrier layer over the substrate in order to protect the substrate from the heat associated with sintering. However, Ladd teaches that aerogels are used as spacer materials when thermally isolating portions of a semiconductor wafer (column 4, lines 15-30). Therefore, it would have been obvious at the time the invention was made to a person having ordinary skill in the art to utilize aerogel, as a thermal barrier, to protect the substrate from damage from the heat produced by the sintering process. Since the materials in the reference are the same as that claimed by the applicant, it is the examiner's position that it is inherent that the aerogel also acts to increase adhesion of the sintered material. As to claims 20 and 41, the semiconductor device taught by Kirkpatrick is an electronic component with a low temperature substrate.

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Claims 24-28 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kirkpatric (US 4,151,008) as applied to claim 22 above, and further in view of Kriegel et al. (US 6,300,256 B1).

Kirkpatrick teaches the limitations of claim 23. Specifically, the limitations of claim 22 are implicitly or inherently taught and the limitations of claim 23, the use of a feedback controller, would have been obvious in order to achieve reproducibility of the process. Kirkpatrick fails to teach the use of a pyrometer with a small spot size in order to provide the input of the feedback controller. However, one skilled in the art would recognize that a temperature would be the desired input for the controller. Additionally, Kriegel teaches using a pyrometer having a small measurement spot to determine the temperature of a semiconductor (column 12, lines 5-10). This is done to ultimately control the temperature and temperature gradients of the semiconductor. The benefit of the pyrometer is that the temperature can be determined without contacting the substrate (column 3, lines 35-37). Therefore, it would have been obvious at the time the invention was made to a person having ordinary skill in the art to utilize the pyrometer having a small spot size in order to determine the temperatures at selected areas of the semiconductor without making any contact that might disturb the system.

To have the pyrometer connected to a computer that controls the parameters of the laser would have been obvious to one skilled in the art. It is the examiner's position that the control loop would inherently have to be either open or closed. To provide an interface for real time use by end users, such as to CAD software, would also have

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been obvious to one skilled in the art such that full automation can be achieved and design changes are instantaneously performed.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Eric B Fuller whose telephone number is (703) 308-6544. The examiner can normally be reached on Tuesday through Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Shrive Beck can be reached on (703) 308-2333. The fax phone numbers for the organization where this application or proceeding is assigned are 703 872-9310 for regular communications and (703) 872-9311 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0661.

April 2, 2002

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